

IGBT - Field Stop II NGTB50N120FL2WG

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop II Trench construction, and provides superior performance in demanding switching applications, offering both low on state voltage and minimal switching loss. The IGBT is well suited for UPS and solar applications. Incorporated into the device is a soft and fast co–packaged free wheeling diode with a low forward voltage.

Features

- Extremely Efficient Trench with Field Stop Technology
- $T_{Jmax} = 175^{\circ}C$
- Soft Fast Reverse Recovery Diode
- Optimized for High Speed Switching
- 10 us Short Circuit Capability
- These are Pb-Free Devices

Typical Applications

- Solar Inverter
- Uninterruptible Power Inverter Supplies (UPS)
- Welding

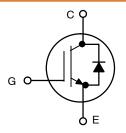
ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-emitter Voltage	V _{CES}	1200	V
Collector Current @ T _C = 25°C @ T _C = 100°C	I _C	100 50	Α
Pulsed Collector Current, T _{pulse} Limited by T _{Jmax}	I _{CM}	200	Α
Diode Forward Current @ T _C = 25°C @ T _C = 100°C	I _F	100 50	А
Diode Pulsed Current, T _{pulse} Limited by T _{Jmax}	I _{FM}	200	Α
Gate-emitter Voltage Transient Gate-emitter Voltage (T _{pulse} = 5 μs, D < 0.10)	V _{GE}	±20 ±30	V
Power Dissipation @ T _C = 25°C @ T _C = 100°C	P _D	535 267	W
Short Circuit Withstand Time $V_{GE} = 15 \text{ V}, V_{CE} = 500 \text{ V}, T_J \le 150^{\circ}\text{C}$	T _{SC}	10	μs
Operating Junction Temperature Range	TJ	–55 to +175	°C
Storage Temperature Range	T _{stg}	-55 to +175	°C
Lead temperature for soldering, 1/8" from case for 5 seconds	T _{SLD}	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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50 A, 1200 V V_{CEsat} = 2.20 V E_{off} = 1.40 mJ





MARKING DIAGRAM



50N120FL2 = Specific Device Code

A = Assembly Location
Y = Year
WW = Work Week

G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
NGTB50N120FL2WG	TO-247 (Pb-Free)	30 Units / Rail

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{ heta JC}$	0.28	°C/W
Thermal resistance junction-to-case, for Diode	$R_{ heta JC}$	0.5	°C/W
Thermal resistance junction-to-ambient	$R_{\theta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
STATIC CHARACTERISTIC		<u>. </u>				
Collector-emitter breakdown voltage, gate-emitter short-circuited	$V_{GE} = 0 \text{ V, } I_{C} = 500 \mu\text{A}$	V _{(BR)CES}	1200	_	-	V
Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 50 A V _{GE} = 15 V, I _C = 50 A, T _J = 175°C	V _{CEsat}	-	2.20 2.60	2.40 -	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 400 \mu A$	$V_{GE(th)}$	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate- emitter short-circuited	V _{GE} = 0 V, V _{CE} = 1200 V V _{GE} = 0 V, V _{CE} = 1200 V, T _{J =} 175°C	I _{CES}	- -	- -	0.1 2.0	mA
Gate leakage current, collector-emitter short-circuited	V _{GE} = 20 V , V _{CE} = 0 V	I _{GES}	-	-	200	nA
DYNAMIC CHARACTERISTIC	•					
Input capacitance		C _{ies}	_	7383	_	pF
Output capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	C _{oes}	_	233	_	
Reverse transfer capacitance	1	C _{res}	-	139	_	
Gate charge total		Q_{g}	_	311	_	nC
Gate to emitter charge	$V_{CE} = 600 \text{ V}, I_{C} = 50 \text{ A}, V_{GE} = 15 \text{ V}$	Q _{ge}	_	64	_	
Gate to collector charge	1	Q _{gc}	_	155	_	1
SWITCHING CHARACTERISTIC, INDUC	TIVE LOAD					
Turn-on delay time		t _{d(on)}	-	118	_	ns
Rise time	1	t _r	-	48	_	
Turn-off delay time	T _J = 25°C	t _{d(off)}	_	282	_	
Fall time	$V_{CC} = 600 \text{ V}, I_{C} = 50 \text{ A}$ $R_{q} = 10 \Omega$	t _f	-	113	_	
Turn-on switching loss	$V_{GE} = 0 \text{ V/ } 15 \text{V}$	E _{on}	-	4.40	_	mJ
Turn-off switching loss	1	E _{off}	_	1.40	_	
Total switching loss	1	E _{ts}	_	5.80	_	
Turn-on delay time		t _{d(on)}	_	114	_	ns
Rise time	1	t _r	_	49	_	
Turn-off delay time	T _J = 175°C	t _{d(off)}	_	298	_	
Fall time	$V_{CC} = 600 \text{ V}, I_{C} = 50 \text{ A}$ $R_{q} = 10 \Omega$	t _f	_	243	_	
Turn-on switching loss	$V_{GE} = 0 \text{ V/ } 15 \text{V}$	E _{on}	_	5.65	_	mJ
Turn-off switching loss	1	E _{off}	_	3.26	_	ĺ
Total switching loss	1	E _{ts}	_	8.91	_	
DIODE CHARACTERISTIC					•	•
Forward voltage	$V_{GE} = 0 \text{ V, } I_F = 50 \text{ A}$ $V_{GE} = 0 \text{ V, } I_F = 50 \text{ A, } T_J = 175^{\circ}\text{C}$	V _F	- -	2.00 2.55	2.60 -	V
Reverse recovery time	T _J = 25°C	t _{rr}	_	256	_	ns
Reverse recovery charge	$I_F = 50 \text{ A}, V_R = 400 \text{ V}$ $di_F/dt = 200 \text{ A}/\mu\text{s}$	Q _{rr}	-	2.7	_	μς
Reverse recovery current	αι _Ε /αι – 200 Α/μο	I _{rrm}	-	19	_	Α
Reverse recovery time	T _J = 175°C	t _{rr}	_	400	_	ns
Reverse recovery charge	$I_F = 40 \text{ A}, V_R = 400 \text{ V}$ $di_F/dt = 200 \text{ A}/\mu\text{s}$	Q _{rr}	-	5.75	_	μς
Reverse recovery current	- αιμ/αι – 200 Α/μο	I _{rrm}	_	27	_	Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

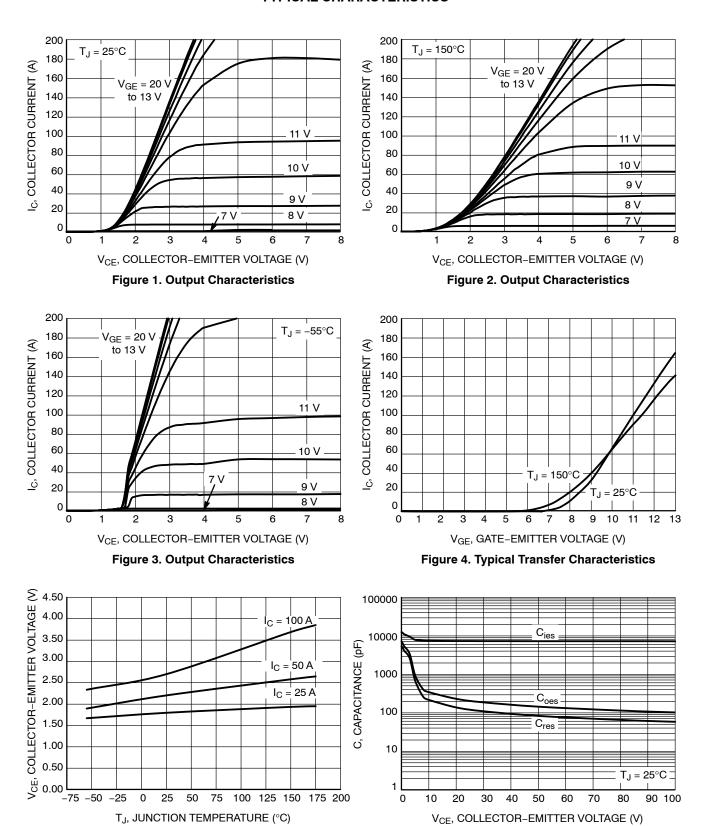


Figure 6. Typical Capacitance

Figure 5. V_{CE(sat)} vs T_J

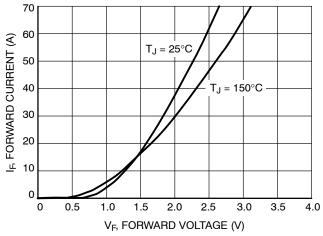


Figure 7. Diode Forward Characteristics

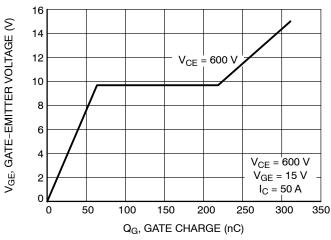


Figure 8. Typical Gate Charge

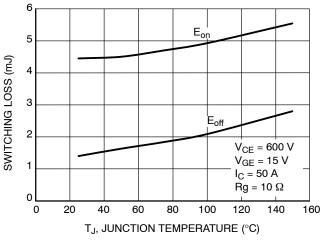


Figure 9. Switching Loss vs. Temperature

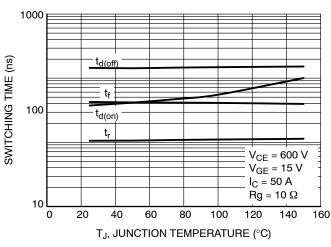


Figure 10. Switching Time vs. Temperature

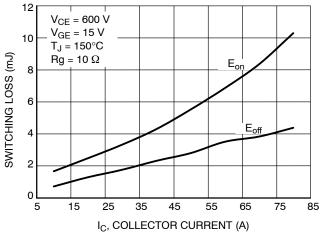


Figure 11. Switching Loss vs. I_C

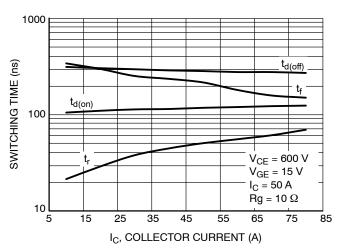


Figure 12. Switching Time vs. I_C

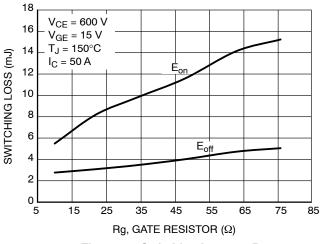


Figure 13. Switching Loss vs. Rg

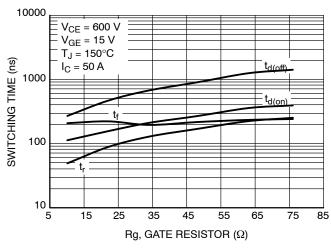


Figure 14. Switching Time vs. Rg

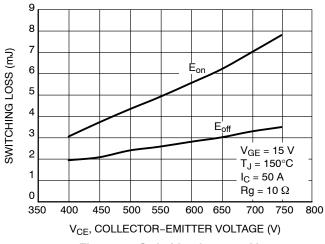


Figure 15. Switching Loss vs. V_{CE}

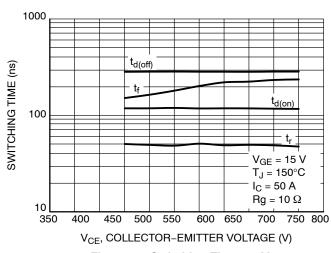


Figure 16. Switching Time vs. V_{CE}

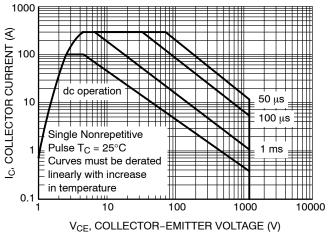


Figure 17. Safe Operating Area

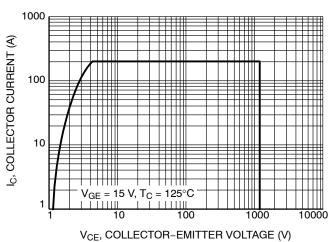
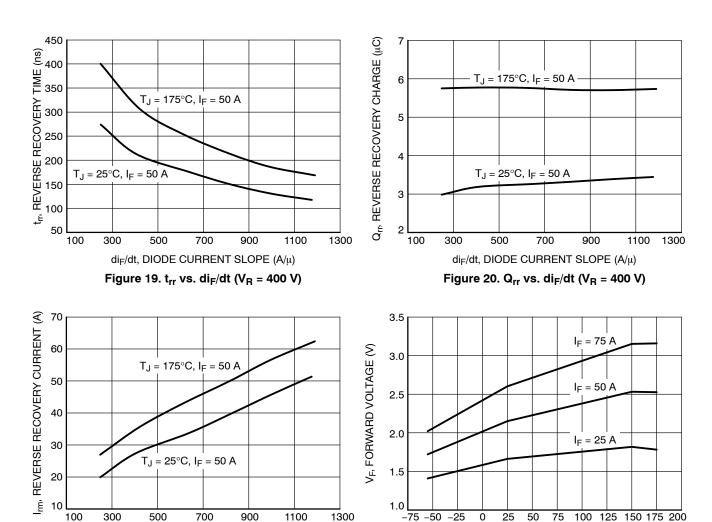


Figure 18. Reverse Bias Safe Operating Area



 $\label{eq:diff} \begin{aligned} &\text{dif/dt, DIODE CURRENT SLOPE (A/μ)} \\ &\text{Figure 21. I}_{rm} \text{ vs. dif/dt (V}_{R} = 400 \text{ V)} \end{aligned}$

 T_J , JUNCTION TEMPERATURE (°C) Figure 22. V_F vs. T_J

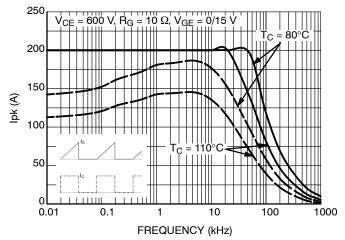


Figure 23. Collector Current vs. Switching Frequency

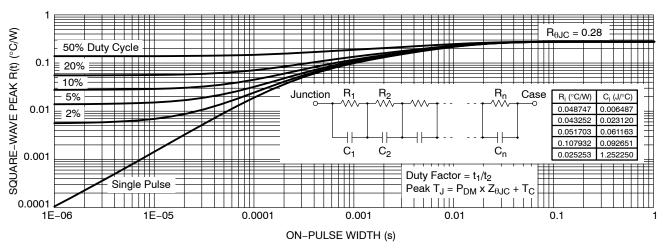


Figure 24. IGBT Transient Thermal Impedance

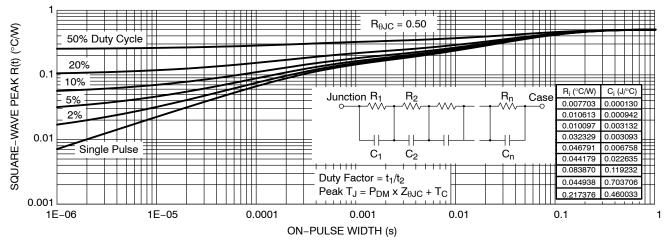
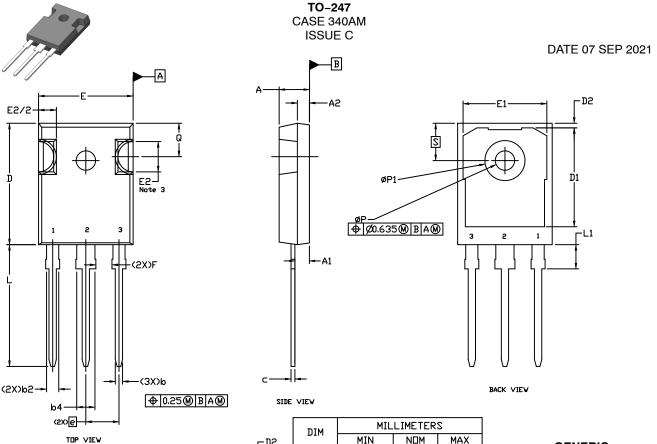
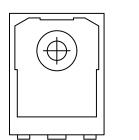
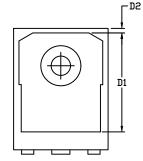


Figure 25. Diode Transient Thermal Impedance









NOTE 4 HEATSINK SHAPES

NOTES:

- 1. DIMENSIONING AND TOLERANCE AS PER ASME Y14.5M, 2009.
- 2. ALL DIMENSION ARE IN MILLIMETERS.
- 3. SLOT REQUIRED, NOTCH MAY BE ROUNDED.
- 4. OPTIONAL BACK SIDE HEATSINK SHAPE.
- 5. DIMENSIONS ARE EXCLUSIVE OF BURRS AND MOLD FLASH.
 DIMENSIONS D AND E ARE MEASURED AT THE DUTERMOST EXTREME
 OF THE PLASTIC BODY.
- 6. DIMENSIONS AT TO BE MEASURED IN THE REGION DEFINED BY L1.
- 7. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

MILLIMETERS		
MIN	NDM	MAX
4.70	5.00	5.30
2,20	2.40	2.60
1.80	2.00	2.20
1.07	1.20	1.33
1.65	2.12	2.35
2.60	3.12	3.40
0.45	0.60	0.75
20.80	21.00	21.34
16.30		
0.75		
15.50	16.00	16.25
13.80		
4.32	4.90	5.49
5	.45 BSC	
2.655		
19.80	20.00	20.80
3.81	4.20	4.35
3.55	3.60	3.65
6.60		
5.40	6.00	6.20
6.15 BSC		
	MIN 4.70 2.20 1.80 1.07 1.65 2.60 0.45 20.80 16.30 0.75 15.50 13.80 4.32 5 2.655 19.80 3.81 3.55 6.60 5.40	MIN NIM 4,70 5,00 2,20 2,40 1,80 2,00 1,07 1,20 1,65 2,12 2,60 3,12 0,45 0,60 20,80 21,00 16,30 15,50 16,00 13,80 4,32 4,90 5,45 BSC 2,655 19,80 20,00 3,81 4,20 3,55 3,60 6,60 5,40 6,00

GENERIC MARKING DIAGRAMS*





XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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